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Application/Control No.	Applicant(s)/Patent under Reexamination	r
10/039,827	CHOW ET AL.	
Examiner	Art Unit	-
Zohreh A. Fav	1618	

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
The parent application was reviewed	6/28/2002	Z.F
STIC Library search	1/25/2005	Z.F
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